## Notice of References Cited Application/Control No. 10/623,510 Examiner Paul Callahan Applicant(s)/Patent Under Reexamination HAMAGUCHI ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,137,409 A	10-2000	Stephens, Bruce Randall	340/568.1
*	В	US-6,970,095 B1	11-2005	Lee et al.	340/669
*	С	US-5,317,304 A	05-1994	Choi, Alexander K.	340/571
*	D	US-5,926,092 A	07-1999	Kim, Seung-chan	340/571
*	Е	US-5,748,083	05-1998	Rietkerk, Anthony J.	340/568.2
*	F	US-5,574,429 A	11-1996	Streeter, Robert W.	340/571
*	G	US-5,757,270	05-1998	Mori, Nobuyuki	340/568.1
*	Н	US-6,529,144 B1	03-2003	Nilsen et al.	341/20
*	1	US-6,133,830 A	10-2000	D'Angelo et al.	340/571
*	j	US-5,748,083	05-1998	Rietkerk, Anthony J.	340/568.2
*	К	US-5,760,690	06-1998	French, Roger Allan	340/571
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.